

NPN General Purpose Amplifier

This device is designed as a general purpose amplifier and switch. The useful dynamic range extends to 100 mA as a switch and to 100 MHz as an amplifier.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	25	V
V _{CBO}	Collector-Base Voltage	30	V
V _{EBO}	Emitter-Base Voltage	5.0	V
I _C	Collector Current - Continuous	200	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.
2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA = 25°C unless otherwise noted

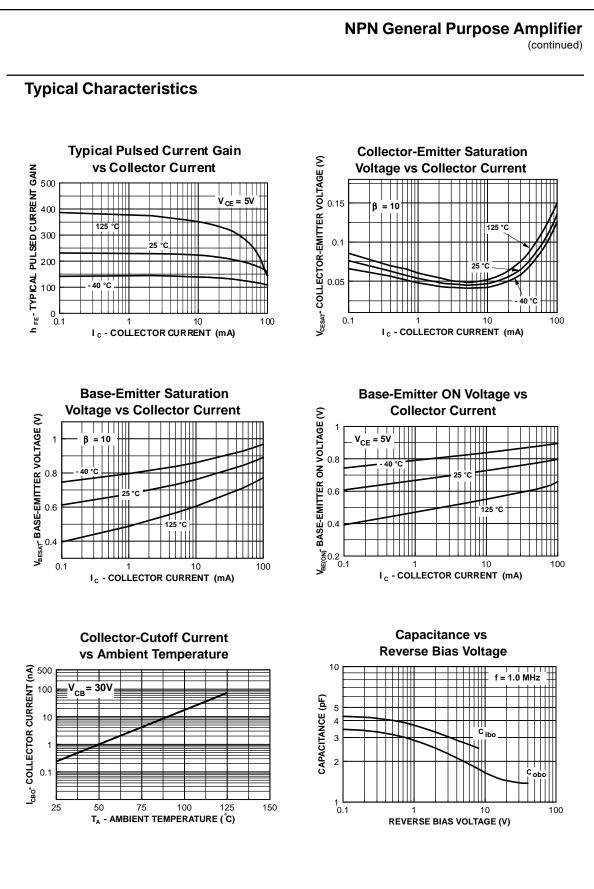
Symbol	Characteristic	Мах		Units	
		2N4124	*MMBT4124		
P _D	Total Device Dissipation	625	350	mW	
	Derate above 25°C	5.0	2.8	mW/°C	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	83.3		°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W	

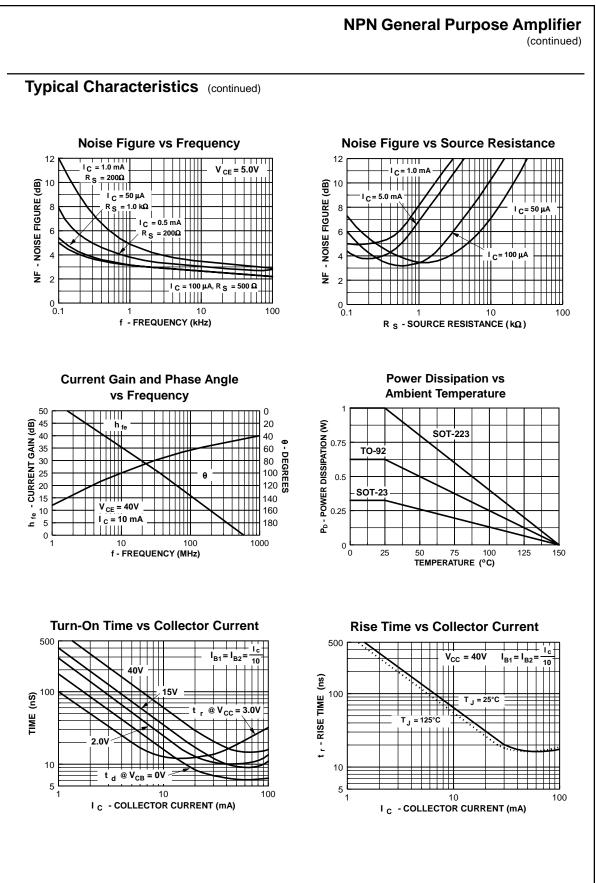
*Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

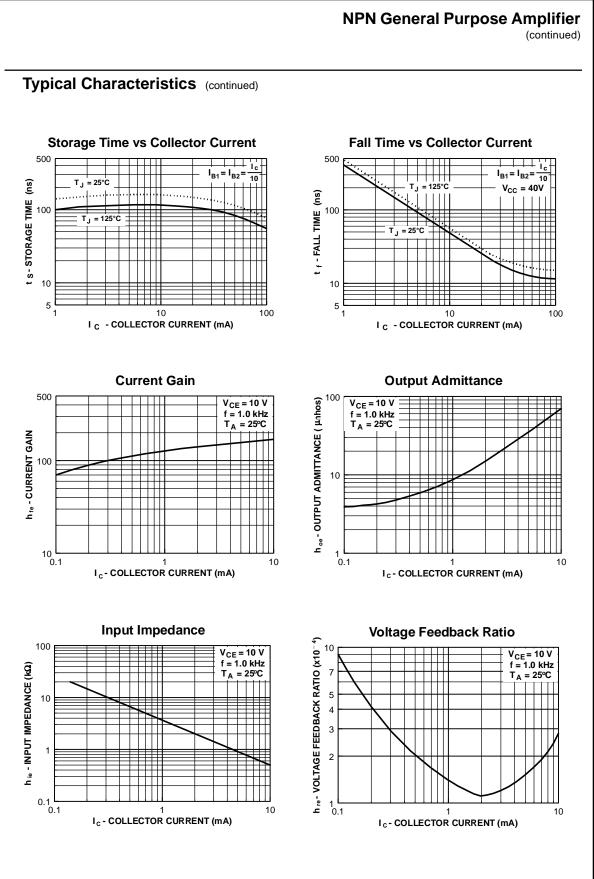
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NPN General Purpose Amplifier (continued)

Symbol	Parameter	Test Conditions	Min	Max	Unit
				<u>.</u>	-
OFF CHA	RACTERISTICS			-	
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage	$I_{\rm C} = 1.0 \text{ mA}, I_{\rm B} = 0$	25		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = 10 \ \mu {\rm A}, \ I_{\rm E} = 0$	30		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_{\rm C} = 10 \ \mu {\rm A}, \ I_{\rm C} = 0$	5.0		V
СВО	Collector Cutoff Current	$V_{CB} = 20 \text{ V}, \text{ I}_{E} = 0$		50	nA
EBO	Emitter Cutoff Current	$V_{EB} = 3.0 \text{ V}, I_{C} = 0$		50	nA
ON CHAR	ACTERISTICS*				
n _{FE}	DC Current Gain	$I_{c} = 2.0 \text{ mA}, V_{cE} = 1.0 \text{ V}$	120 60	360	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_{C} = 50 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_{C} = 50 \text{ mA}, I_{B} = 5.0 \text{ mA}$	00	0.3	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	$I_{\rm C} = 50 \text{ mA}, I_{\rm B} = 5.0 \text{ mA}$		0.95	V
		f = 100 MHz	300	4.0	
	GNAL CHARACTERISTICS Current Gain - Bandwidth Product	$I_{\rm C} = 10 \text{ mA}, V_{\rm CE} = 20 \text{ V},$ f = 100 MHz	300		MHz
Cobo	Output Capacitance	$V_{CB} = 5.0 \text{ V}, I_E = 0,$ f = 100 kHz		4.0	pF
Cibo	Input Capacitance	$V_{BE} = 0.5 \text{ V}, I_C = 0,$ f = 1.0 kHz		8.0	pF
C _{cb}	Collector-Base Capcitance Small-Signal Current Gain		120	4.0 480	pF
{fe} NF	Noise Figure	$V{CE} = 10 \text{ V}, \text{ I}_{C} = 2.0 \text{ mA},$ f = 1.0 kHz I _C = 100 μ A, V _{CE} = 5.0 V,	120	5.0	dB
NI		$R_{s} = 1.0 k\Omega$, f=10 Hz to 15.7 kHz		5.0	UD
*Pulse Test: I	Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%				







NPN General Purpose Amplifier (continued)

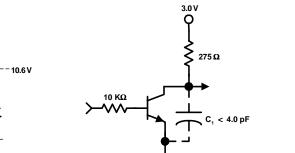
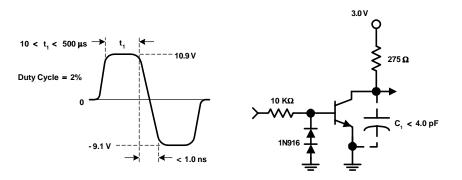


FIGURE 1: Delay and Rise Time Equivalent Test Circuit

➡ 300 ns ा 🗲

< 1.0 ns 🔸





Test Circuits

Duty Cycle = 2%

0 - 0.5 V

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